

Issue Classification		Application/Control No. 10769826		Applicant(s)/Patent under Reexamination REBER ET AL.																																											
		Examiner Nguyen, Kimhung		Art Unit 2629																																											
<table border="1"> <thead> <tr> <th colspan="2">ORIGINAL</th> <th colspan="6">INTERNATIONAL CLASSIFICATION</th> </tr> <tr> <th rowspan="2">CLASS</th> <th rowspan="2">SUBCLASS</th> <th colspan="3">CLAIMED</th> <th colspan="2">NON-CLAIMED</th> </tr> <tr> <th>G</th> <th>0</th> <th>6</th> <th>T</th> <th colspan="2">11 / 00</th> </tr> </thead> <tbody> <tr> <td>345</td> <td>471</td> <td></td> <td></td> <td></td> <td></td> <td></td> </tr> </tbody> </table> <p>CROSS REFERENCE(S)</p> <table border="1"> <thead> <tr> <th colspan="2">SUBCLASS (ONE SUBCLASS PER BLOCK)</th> </tr> </thead> <tbody> <tr> <td>345</td> <td>169</td> <td>467</td> <td></td> <td></td> <td></td> </tr> <tr> <td>434</td> <td>178</td> <td></td> <td></td> <td></td> <td></td> </tr> </tbody> </table>						ORIGINAL		INTERNATIONAL CLASSIFICATION						CLASS	SUBCLASS	CLAIMED			NON-CLAIMED		G	0	6	T	11 / 00		345	471						SUBCLASS (ONE SUBCLASS PER BLOCK)		345	169	467				434	178				
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 <i>[Handwritten signature]</i>		Kimhung Nguyen (Primary Examiner) (Date)		Total Claims Allowed: 5																																											
Kimmhung Nguyen (Assistant Examiner) (Date)		10/16/06		O.G. Print Claim(s) 1																																											
<i>[Handwritten signature]</i> Legal Instruments Examiner (Date)		10/24/06 (Date)		O.G. Print Figure 1																																											

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